

Ultra-Small, Single-Channel, 8-/10-/12-Bit Buffered Output Voltage DACs with Internal Reference and I²C Interface

General Description

The MAX5803/MAX5804 single-channel, low-power, 8-/10-/12-bit, voltage-output this is an addition to content digital-to-analog converters (DACs) include output buffers and an internal reference that is selectable to be 2.048V, 2.500V, or 4.096V. The MAX5803/MAX5804/ MAX5805 accept a wide supply voltage range of 2.7V to 5.5V with extremely low power (< 1mW) consumption to accommodate most low-voltage applications. A precision external reference input allows rail-to-rail operation and presents a 100k Ω (typ) load to an external reference.

The MAX5803/MAX5804/MAX5805 have an I²Ccompatible, 2-wire interface that operates at clock rates up to 450kHz. The DAC output is buffered and has a low supply current of 155 μ A (typical at 3.5V) and a low offset error of ±0.5mV (typical). On power-up, the MAX5803/MAX5804/MAX5805 reset the DAC outputs to zero, providing additional safety for applications that drive valves or other transducers which need to be off on power-up.

The MAX5803/MAX5804/MAX5805 include a userconfigurable active-low asynchronous input, AUX for additional flexibility. This input can be programmed to asynchronously clear (CLR) or temporarily gate (GATE) the DAC output to a user-programmable value. A dedicated active-low asynchronous LDAC input is also included. This allows simultaneous output updates of multiple devices.

The MAX5803/MAX5804/MAX5805 are available in 10-pin TDFN/ μ MAX® packages and are specified over the -40°C to +125°C temperature range.

Applications

Programmable Voltage and Current Sources Gain and Offset Adjustment Automatic Tuning and Optical Control Power Amplifier Control and Biasing Process Control and Servo Loops Portable Instrumentation

Data Acquisition

Benefits and Features

- Single High-Accuracy DAC Channel
 12-Bit Accuracy Without Adjustments
 - ♦ ±1 LSB INL Buffered Voltage Output
 - ♦ Guaranteed Monotonic Over All Operating Conditions
- Internal Output Buffer
 Rail-to-Rail Operation with External Reference
 - \Rightarrow 6.3µs Settling Time
 - \diamond Output Directly Drives 2k Ω Loads
- ♦ Small, 10-Pin, 2mm x 3mm TDFN and 3mm x 5mm µMAX Packages
- ♦ Wide 2.7V to 5.5V Supply Range
- Fast 400kHz I²C-Compatible, 2-Wire Serial Interface with Readback Capability
- Power-On-Reset to Zero-Scale DAC Output
- ◆ User-Configurable Asynchronous I/O Functions: CLR, LDAC, GATE
- Three Software-Selectable Power-Down Output Impedances: 1kΩ, 100kΩ, or High Impedance

Functional Diagram

Low 155µA DAC Supply Current at 3V

VDDIO VDD REF MAX5803 INTERNAL REFERENCE / MAX5804 EXTERNAL BUFFER MAX5805 SCL 8-/10-/ CODE DAC 12-BIT SDA REGISTER LATCH DAC OUT BUFFFR 12C ADDR SFRIAI NTERFACE AUX CLEAR / CLEAR/ CODE LOAD GATE LDAC RESET RESET $100k\Omega$ $1k\Omega$ POWER DAC CONTROL LOGIC DOWN POR GND

Ordering Information appears at end of data sheet.

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For related parts and recommended products to use with this part, refer to: www.maximintegrated.com/MAX5803.related

For pricing, delivery, and ordering information, please contact Maxim Direct at 1-888-629-4642, or visit Maxim's website at www.maximintegrated.com.

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ABSOLUTE MAXIMUM RATINGS

V _{DD} to GND	0.3V to +6V
V _{DDIO} to GND	0.3V to +6V
OUT, REF to GND0.3V to lower of (V _{DD}	
SCL, SDA, AUX, LDAC to GND	0.3V to +6V
ADDR to GND	0.3V to lower of
(V _{DDIC}) + 0.3V) and +6V
Continuous Power Dissipation ($T_A = +70^{\circ}C$)	
TDFN (derate 14.9mW/°C above +70°C)	1188.7mW
µMAX (derate 8.8mW/°C above +70°C)	707.3mW

Maximum Continuous Current into Any Pin	±50mA
Operating Temperature Range	40°C to +125°C
Storage Temperature Range	65°C to +150°C
Lead Temperature (soldering, 10s)	+300°C
Soldering Temperature (reflow)	+260°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

PACKAGE THERMAL CHARACTERISTICS (Note 1)

TDFN

Junction-to-Ambient Thermal Resistance (θ_{JA})......67.3°C/W μ MAX Junction-to-Ambient Thermal Resistance (θ_{JA}).....113.1°C/W

Note 1: Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to www.maximintegrated.com/thermal-tutorial.

ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS		
DC PERFORMANCE (Note 3)								
		MAX5803	8					
Resolution and Monotonicity	N	MAX5804	10			Bits		
		MAX5805	12		+0.25 +0.5 +1			
		MAX5803, 8 bits	-0.25	±0.05	+0.25			
Integral Nonlinearity (Note 4)	INL	MAX5804, 10 bits	-0.5	±0.2	+0.5	LSB		
		MAX5805, 12 bits	-1	±0.5	+1			
		MAX5803, 8 bits	-0.25	±0.05	+0.25			
Differential Nonlinearity (Note 4)	DNL	MAX5804, 10 bits	-0.5	±0.1	+0.5	LSB		
		MAX5805, 12 bits	-1	±0.2	+1			
Offset Error (Note 5)	OE		-5	±0.5	+5	mV		
Offset Error Drift				±10		µV/°C		
Gain Error (Note 5)	GE		-1.0	±0.1	+1.0	%FS		
Gain Temperature Coefficient		With respect to V _{REF}		±2.5		ppm of FS/°C		
Zero-Scale Error			0		+10	mV		
Full-Scale Error		With respect to V _{REF}	-0.5		+0.5	%FS		

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ELECTRICAL CHARACTERISTICS (continued)

PARAMETER	SYMBOL	CONDITIONS		MIN	ТҮР	MAX	UNITS
DAC OUTPUT CHARACTERISTIC	CS						
		No load		0		V _{DD}	
Output Voltage Range (Note 6)		2k Ω load to GND		0		V _{DD} - 0.2	V
		2k Ω load to V _{DD}		0.2		V _{DD}	
Load Degulation			$V_{DD} = 3V \pm 10\%,$ $II_{OUT}I \le 5mA$		300		
Load Regulation		$V_{OUT} = V_{FS}/2$	$V_{DD} = 5V \pm 10\%,$ $ I_{OUT} \le 10mA$		300		μV/mA
			$V_{DD} = 3V \pm 10\%,$ $II_{OUT}I \le 5mA$		0.3		
DC Output Impedance		$V_{OUT} = V_{FS}/2$	$V_{DD} = 5V \pm 10\%,$ $ I_{OUT} \le 10mA$		0.3		Ω
Capacitive Load Handling	CL				500		рF
Resistive Load Handling	RL			2			kΩ
		V _{DD} = 5.5V	Sourcing (output short to GND)		30		
Short-Circuit Output Current			Sinking (output shorted to V _{DD})		40		mA
DYNAMIC PERFORMANCE		•		·			
Voltage-Output Slew Rate	SR	Positive and negative	/e		2.0		V/µs
		1/4 scale to 3/4 scale,	to \leq 1 LSB, MAX5803		2.8		
Voltage-Output Settling Time		¹ ⁄ ₄ scale to ³ ⁄ ₄ scale,	to \leq 1 LSB, MAX5804		5.2		μs
		$\frac{1}{4}$ scale to $\frac{3}{4}$ scale, to \leq 1 LSB, MAX5805			6.3		
DAC Glitch Impulse		Major code transition			5.0		nV∙s
Digital Feedthrough		Code = 0, all digital inputs from 0V to VDDIO			0.5		nV∙s
		Startup calibration t	ime (Note 7)		200		μs
Power-Up Time		From power-down r	node		60		μs
DC Power-Supply Rejection		$V_{DD} = 3V \pm 10\% \text{ or }$	5V ±10%		100		μV/V

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ELECTRICAL CHARACTERISTICS (continued)

PARAMETER	SYMBOL	L CONDITIONS		MIN TYP	MAX	UNITS
		Enternal astronome	f = 1kHz	88		
		External reference	f = 10kHz	79		1
		2.048V internal	f = 1kHz	108		
Output Voltage-Noise Density		reference	f = 10 kHz	98		
(DAC Output at Midscale)		2.5V internal	f = 1kHz	117		nV/√Hz
	reference	reference	f = 10 kHz	110		
		4.096V internal	f = 1kHz	152		
		reference	f = 10 kHz	145		
		External reference	f = 0.1Hz to 10Hz	10		
			f = 0.1Hz to $10kHz$	72]
			f = 0.1Hz to 300kHz	298		1
			f = 0.1Hz to 10Hz	11]
		2.048V internal reference	f = 0.1Hz to 10kHz	89]
Integrated Output Noise			f = 0.1Hz to 300kHz	370		
(DAC Output at Midscale)		2.5V internal reference	f = 0.1Hz to 10Hz	12		μV _{P-P}
			f = 0.1Hz to $10kHz$	99		1
			f = 0.1Hz to 300kHz	355]
		4.0001/11.0001	f = 0.1Hz to 10Hz	13		
		4.096V internal reference	f = 0.1Hz to $10kHz$	128		
			f = 0.1Hz to $300kHz$	400		
		External reference	f = 1kHz	113		
			f = 10kHz	100		1
		2.048V internal	f = 1 kHz	172		
Output Voltage-Noise Density		reference	f = 10kHz	157		
(DAC Output at Full Scale)		2.5V internal	f = 1kHz	195		nV/√Hz
		reference	f = 10 kHz	180		
		4.096V internal	f = 1kHz	279		
		reference	f = 10kHz	258		1
			f = 0.1Hz to 10Hz	12		1
		External reference	f = 0.1Hz to $10kHz$	88		
			f = 0.1Hz to $300kHz$	280		
			f = 0.1Hz to 10Hz	14		
		2.048V internal reference	f = 0.1Hz to $10kHz$	135		
Integrated Output Noise			f = 0.1Hz to 300kHz	530		
(DAC Output at Full Scale)		0.5\/ inter-sl	f = 0.1Hz to 10Hz	15		μV _{P-P}
		2.5V internal reference	f = 0.1Hz to $10kHz$	160		
			f = 0.1Hz to 300kHz	550		-
			f = 0.1Hz to 10Hz	23		
	4.096V internal reference		f = 0.1Hz to $10kHz$	220		-
			f = 0.1Hz to 300kHz	610		

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ELECTRICAL CHARACTERISTICS (continued)

PARAMETER	SYMBOL	CO	NDITIONS	MIN	TYP	MAX	UNITS	
REFERENCE INPUT	1	1						
Reference Input Range	V _{REF}			1.24		V _{DD}	V	
Reference Input Current	I _{REF}	$V_{\text{REF}} = V_{\text{DD}} = 5.5$	1		55	75	μA	
Reference Input Impedance	R _{REF}			75	100		kΩ	
REFERENCE OUPUT	1	1					,	
		V _{REF} = 2.048V, T _A	= +25°C	2.043	2.048	2.053		
Reference Output Voltage	V _{REF}	V _{REF} = 2.5V, T _A =	+25°C	2.494	2.500	2.506	V	
		$V_{REF} = 4.096V, T_{A}$		4.086	4.096	4.106		
			f = 1kHz		129			
		$V_{REF} = 2.048 V$	f = 10kHz		122			
		$V_{REF} = 2.500V$	f = 1kHz		158		nV/√Hz	
Reference Output Noise Density			f = 10kHz		151			
			f = 1kHz		254			
		$V_{REF} = 4.096V$	f = 10kHz		237			
			f = 0.1Hz to 10Hz		12		μν _{Ρ-Ρ}	
		V _{REF} = 2.048V	f = 0.1Hz to $10kHz$		110			
			f = 0.1Hz to 300kHz		390			
late success of Defenses and Output			f = 0.1Hz to $10Hz$		15			
Integrated Reference Output Noise		$V_{REF} = 2.500V$	f = 0.1Hz to $10kHz$		129			
			f = 0.1Hz to $300kHz$		430			
			f = 0.1Hz to $10Hz$		20			
		$V_{REF} = 4.096V$	f = 0.1Hz to $10kHz$		205			
			f = 0.1Hz to $300kHz$		525			
Reference Temperature		MAX5805A			±4	±12	/^	
Coefficient (Note 8)		MAX5803/MAX5804/MAX5805B			±10	±25	ppm/°C	
Reference Drive Capacity		External load			25		kΩ	
Reference Capacitive Load Handling					200		pF	
Reference Load Regulation		$I_{\text{SOURCE}} = 0$ to 50	ΟμΑ		1.0		mV/mA	
Reference Line Regulation				1	0.1		mV/V	

Ultra-Small, Single-Channel, 8-/10-/12-Bit Buffered Output Voltage DACs with Internal Reference and I²C Interface

ELECTRICAL CHARACTERISTICS (continued)

PARAMETER	SYMBOL	CONDITIONS		MIN	ТҮР	MAX	UNITS
POWER REQUIREMENTS	·						
Cuentu Valtara		$V_{REF} = 4.096V$		4.5		5.5	V
Supply Voltage	V _{DD}	All other options		2.7		5.5	V
I/O Supply Voltage	V _{DDIO}			1.8		5.5	V
		External reference	$V_{\text{REF}} = 3V$		135	190	
			$V_{\text{REF}} = 5V$		165	225	
		Internal reference,	V _{REF} = 2.048V		190	265	
Supply Current (DAC Output at		reference pin	$V_{\text{REF}} = 2.5V$		205	280	
Midscale) (Note 9)	IDD	undriven	V _{REF} = 4.096V		250	340	μA
			V _{REF} = 2.048V		215	300	
		Internal reference, reference pin driven	$V_{\text{REF}} = 2.5V$		225	315	
			$V_{REF} = 4.096V$		275	375	1
		Fortenne el meterre e e	$V_{REF} = 3V$		155	210	μA
		External reference	$V_{REF} = 5V$		200	265	
		Internal reference,	V _{REF} = 2.048V		205	280	
Supply Current (DAC Output at		reference pin	$V_{REF} = 2.5 V$		220	300	
Full Scale) (Note 9)	IDD	undriven	$V_{REF} = 4.096V$		275	375	
		Internal reference, reference pin driven	V _{REF} = 2.048V		225	310	
			$V_{\text{REF}} = 2.5 V$		240	330	
			V _{REF} = 4.096V		300	410	
Power-Down Mode Supply			$V_{REF} = 2.048V$		90	135	μA
Current (DAC Powered Down, Reference Remains Active)	IDD	Internal reference, reference pin driven	$V_{\text{REF}} = 2.5 V$		93	135	
(Note 9)			V _{REF} = 4.096V		100	150	
Power-Down Mode Supply Current (Note 9)	I _{PD}	External reference, V	_{DD} = V _{REF}		0.4	2	μA
Digital Supply Current (Note 9)	IDDIO					1.0	μA
DIGITAL INPUT CHARACTERIS	TICS (SCL, S	DA, ADDR, AUX, LDA	<u>C</u>)				
		2.2V < V _{DDIO} < 5.5V		0.7 x V _{DDIO}			
Input High Voltage	V _{IH}	1.8V < V _{DDIO} < 2.2V		0.8 x V _{DDIO}			
		2.2V < V _{DDIO} < 5.5V				0.3 x V _{DDIO}	
Input Low Voltage	VIL	1.8V < V _{DDIO} < 2.2V				0.2 x V _{DDIO}	V

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ELECTRICAL CHARACTERISTICS (continued)

 $(V_{DD} = 2.7V \text{ to } 5.5V, V_{DDIO} = 1.8V \text{ to } 5.5V, V_{GND} = 0V, C_L = 200pF, R_L = 2k\Omega$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$, unless otherwise noted.) (Note 2)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS
Hysteresis Voltage	V _H			0.15		V
Input Leakage Current (Note 9)	I _{IN}			±0.1	±1	μA
Input Capacitance	C _{IN}			3		pF
ADDR Pullup/Pulldown Strength	R _{PU} , R _{PD}	(Note 10)	30	50	90	kΩ
DIGITAL OUTPUT (SDA)		•				
Output Low Voltage	V _{OL}	I _{SINK} = 3mA			0.2	V
I ² C TIMING CHARACTERISTICS		AUX, LDAC)				
SCL Clock Frequency	f _{SCL}				400	kHz
Bus Free Time Between a STOP and a START Condition	t _{BUF}		1.3			μs
Hold Time Repeated for a START Condition	t _{HD;STA}		0.6			μs
SCL Pulse Width Low	t _{LOW}		1.3			μs
SCL Pulse Width High	thigh		0.6			μs
Setup Time for Repeated START Condition	^t SU;STA		0.6			μs
Data Hold Time	thd;dat		0		900	ns
Data Setup Time	t _{SU;DAT}		100			ns
SDA and SCL Receiving Rise Time	t _R		20 + C _B /10		300	ns
SDA and SCL Receiving Fall Time	tF		20 + C _B /10		300	ns
SDA Transmitting Fall Time	tF		20 + C _B /10		250	ns
Setup Time for STOP Condition	t _{SU;STO}		0.6			μs
Bus Capacitance Allowed	CB	$V_{DD} = 2.7V$ to 5.5V	10		400	pF
Pulse Width of Suppressed Spike	t _{SP}			50		ns
CLR Removal Time Prior to a Recognized START	^t CLRSTA		100			ns
CLR Pulse Width Low	^t CLPW		20			ns
LDAC Pulse Width Low	t _{LDPW}		20			ns
LDAC Fall to SCLK Fall to Hold	t _{LDH}	Applies to execution edge	400			ns

Ultra-Small, Single-Channel, 8-/10-/12-Bit Buffered Output Voltage DACs with Internal Reference and I²C Interface

ELECTRICAL CHARACTERISTICS (continued)

 $(V_{DD} = 2.7V \text{ to } 5.5V, V_{DDIO} = 1.8V \text{ to } 5.5V, V_{GND} = 0V, C_L = 200pF, R_L = 2k\Omega$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$, unless otherwise noted.) (Note 2)

- **Note 2:** Electrical specifications are production tested at $T_A = +25^{\circ}C$. Specifications over the entire operating temperature range are guaranteed by design and characterization. Typical specifications are at $T_A = +25^{\circ}C$.
- **Note 3:** DC Performance is tested without load.
- Note 4: Linearity is tested with unloaded outputs to within 20mV of GND and VDD.
- **Note 5:** Gain and offset calculated from measurements made with $V_{REF} = V_{DD}$ at code 30 and 4065 for MAX5805, code 8 and 1016 for MAX5804, and code 2 and 254 for MAX5803.
- Note 6: Subject to zero and full-scale error limits and V_{REF} settings.
- Note 7: On power-up, the device initiates an internal 200µs (typ) calibration sequence. All commands issued during this time will be ignored.
- Note 8: Specification is guaranteed by design and characterization.
- **Note 9:** Static logic inputs with $V_{IL} = V_{GND}$ and $V_{IH} = V_{DDIO}$.
- Note 10: An unconnected condition on ADDR is sensed via a resistive pullup and pulldown operation; for proper operation, ADDR should be tied to V_{DDIO} GND, or left unconnected with minimal capacitance.

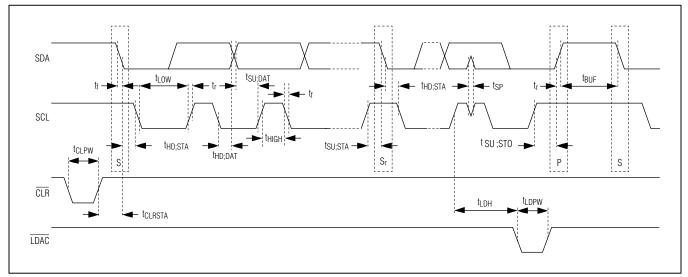


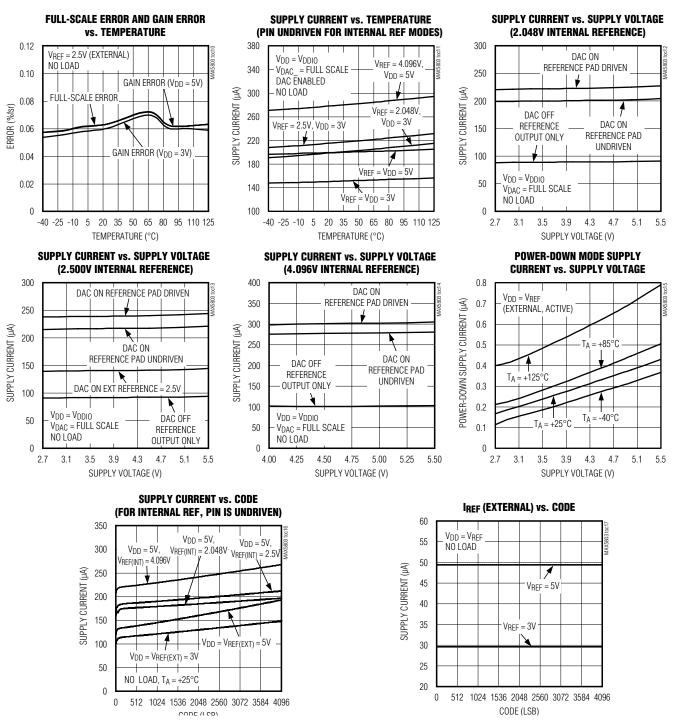
Figure 1. I²C Serial Interface Timing Diagram

(MAX5805, 12-bit performance, $T_A = +25^{\circ}C$, unless otherwise noted.)

INL vs. CODE **INL vs. CODE DNL vs. CODE** 1.0 1.0 05 VDD = VREF = 3V $V_{DD} = V_{REF} = 5V$ $V_{DD} = V_{REF} = 3V$ 0.8 0.8 0.4 NO LOAD NO LOAD NO LOAD 0.6 0.6 0.3 0.4 0.4 0.2 0.2 0.2 0.1 INL (LSB) INL (LSB) DNL (LSB) tota inte אינים אי .16 0 0 0 -0.2 -0.2 -0.1 -0.4 -0.4 -02 -0.6 -0.6 -0.3 -0.8 -0.8 -0.4 -1.0 -1.0 -0.5 512 1024 1536 2048 2560 3072 3584 4096 512 1024 1536 2048 2560 3072 3584 4096 0 0 512 1024 1536 2048 2560 3072 3584 4096 0 CODE (LSB) CODE (LSB) CODE (LSB) DNL vs. CODE INL AND DNL vs. SUPPLY VOLTAGE INL AND DNL vs. TEMPERATURE 0.5 1.0 1.0 $V_{DD} = V_{REF} = 5V$ VDD = VREF VDD = VREF = 3V 0.4 0.8 0.8 NO LOAD 0.3 0.6 0.6 MAX INL MAX INL MAX DN MAX DNL 0.2 0.4 0.4 Ţ 0.1 ERROR (LSB) 0.2 ERROR (LSB) 0.2 (LSB) للمريدا وألمراني بالبلايات أوار أوالشابان الأواب أواليا وأنابيا والمتريك والمراجل 0 0 0 R **A** -0.1 -0.2 -0.2 4 -0.4 -0.4 MIN DNL -0.2 MIN DNL MIN INI -0.3 -0.6 -0.6 MIN INL -04 -0.8 -0.8 -0.5 -1.0 -1.0 512 1024 1536 2048 2560 3072 3584 4096 -40 -25 -10 5 20 35 50 65 80 95 110 125 0 27 3.1 35 3.9 4.3 4.7 51 55 CODE (LSB) SUPPLY VOLTAGE (V) TEMPERATURE (°C) **OFFSET AND ZERO-SCALE ERROR OFFSET AND ZERO-SCALE ERROR FULL-SCALE ERROR AND GAIN ERROR** vs. SUPPLY VOLTAGE vs. TEMPERATURE vs. SUPPLY VOLTAGE 0.40 1.0 -0.02 VREF = 2.5V (EXTERNAL) VREF = 2.5V (EXTERNAL) 0.8 0.35 NO LOAD NO LOAD -0.03 0.6 0.30 -0.04 ZERO-SCALE ERROR 0.4 FULL-SCALE ERROR 0.25 OFFSET ERROR -0.05 (mV) ERROR (% fs) ERROR (mV) 0.2 ERROR (I 0 0.20 -0.06 OFFSET ERROR (VDD = 3V) -0.2 OFFSET ERROR (VDD = 5V) 0.15 -0.07 GAIN ERROR ZERO-SCALE ERROR -0.4 0.10 -0.08 -0.6 VREF = 2.5V (EXTERNAL) 0.05 -0.09 -0.8 NO LOAD 0 -1.0 -0.10 2.7 3.1 3.5 3.9 4.3 4.7 5.1 5.5 -40 -25 -10 5 20 35 50 65 80 95 110 125 2.7 3.1 3.5 3.9 4.3 4.7 5.1 5.5 SUPPLY VOLTAGE (V) TEMPERATURE (°C) SUPPLY VOLTAGE (V)

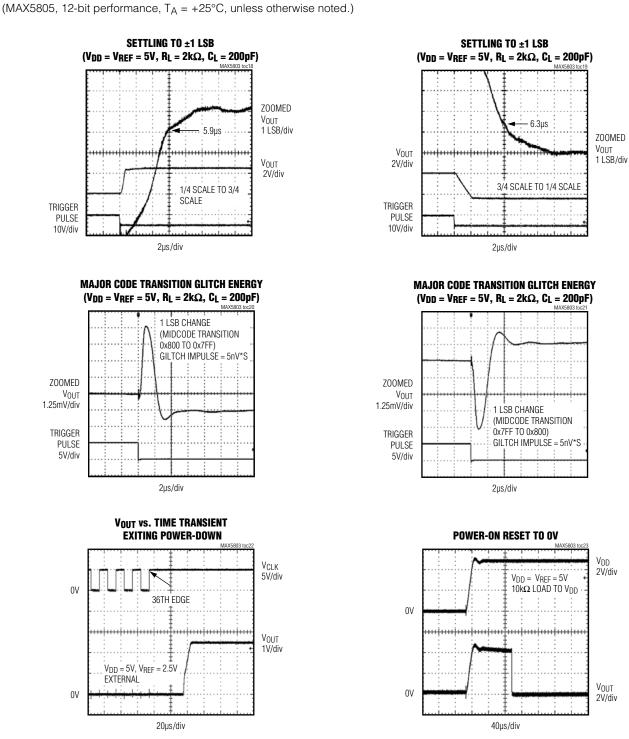
Typical Operating Characteristics

Maxim Integrated



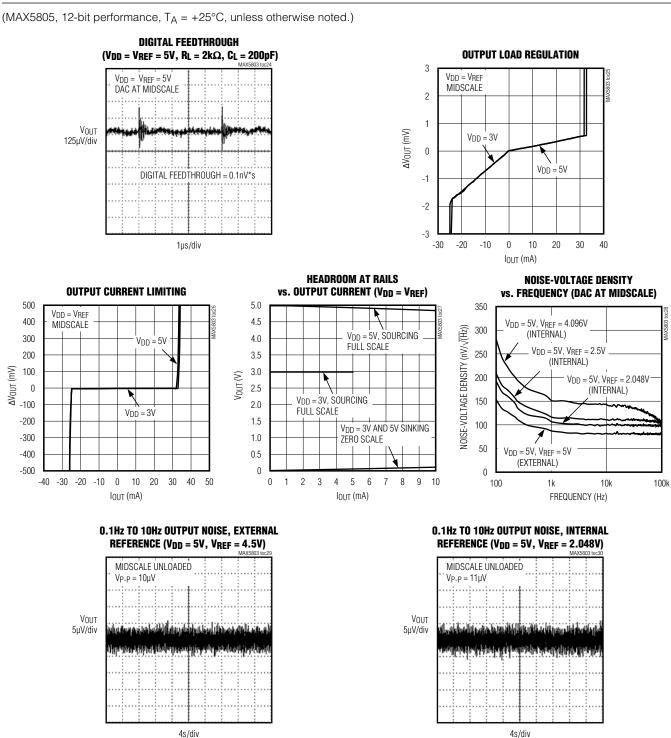
Typical Operating Characteristics (continued)

(MAX5805, 12-bit performance, $T_A = +25^{\circ}C$, unless otherwise noted.)



Typical Operating Characteristics (continued)

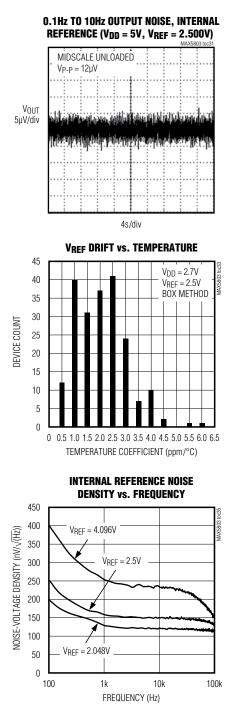
Maxim Integrated

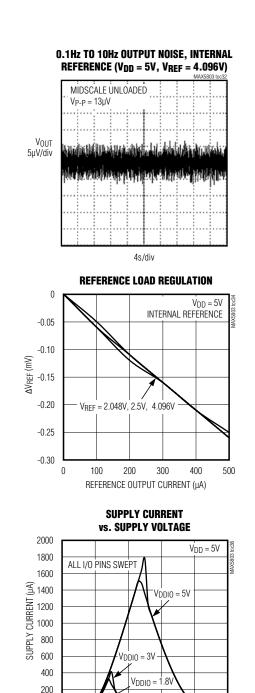


Typical Operating Characteristics (continued)

Maxim Integrated

(MAX5805, 12-bit performance, $T_A = +25^{\circ}C$, unless otherwise noted.)





0

0

1

2

INPUT LOGIC VOLTAGE (V)

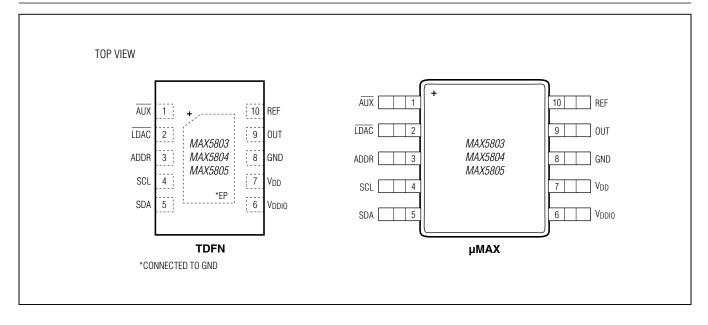
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4

5

Typical Operating Characteristics (continued)

Pin Configurations



Pin Description

PIN	NAME	FUNCTION
1	AUX	Active-Low Auxilliary Asynchronous Input. User Configurable, see Table 7.
2	LDAC	Dedicated Active-Low Asynchronous Load DAC
3	ADDR	I ² C Interface Address Selection
4	SCL	I ² C Interface Clock Input
5	SDA	I ² C Bidirectional Serial Data
6	VDDIO	Digital Interface Power-Supply Input
7	VDD	Supply Voltage Input. Bypass VDD with a 0.1µF capacitor to GND.
8	GND	Ground
9	OUT	Buffered DAC Output
10	REF	Reference Voltage Input/Output
_	EP	Exposed Pad (TDFN Only). Connect to ground.

Detailed Description

The MAX5803/MAX5804/MAX5805 are single-channel, low-power, 8-/10-/12-bit voltage-output digital-to-analog converters (DACs) with an internal output buffer. The wide supply voltage range of 2.7V to 5.5V and low power consumption accommodate low-power and lowvoltage applications. The devices present a $100k\Omega$ (typ) load to the external reference. The internal output buffer allows rail-to-rail operation. An internal voltage reference is available with software selectable options of 2.048V, 2.500V, or 4.096V. The devices feature a fast 400kHz I²C-compatible interface. The MAX5803/ MAX5804/MAX5805 include a serial-in/parallel-out shift register, internal CODE and DAC registers, a power-onreset (POR) circuit to initialize the DAC output to code zero, and control logic. A user-configurable AUX pin is available to asynchronously clear or gate the device output independent of the serial interface.

DAC Output (OUT)

The MAX5803/MAX5804/MAX5805 include an internal buffer on the DAC output. The internal output buffer provides improved load regulation for the DAC output. The output buffer slews at 1V/µs (typ) and drives up to 2k Ω in parallel with 500pF. The analog supply voltage (V_{DD}) determines the maximum output voltage range of the devices as V_{DD} powers the output buffer. Under no-load conditions, the output buffer drives from GND to V_{DD}, subject to offset and gain errors. With a 2k Ω load to GND, the output buffer drives from GND to within and 200mV of V_{DD}. With a 2k Ω load to V_{DD}, the output buffer drives from V_{DD} to within 200mV of GND.

The DAC ideal output voltage is defined by:

$$V_{OUT} = V_{REF} \times \frac{D}{2^N}$$

Where D = code loaded into the DAC register, V_{REF} = reference voltage, N = resolution.

Internal Register Structure

The user interface is separated from the DAC logic to minimize digital feedthrough. Within the serial interface is an input shift register, the contents of which can be routed to control registers or the DAC itself, as determined by the user command.

Within the device there is a CODE register followed by a DAC Latch register (see the *Functional Diagram*).

 of the DAC register hold the current DAC output settings. The DAC register can be updated directly from the serial interface using the CODE_LOAD commands or can upload the current contents of the CODE register using LOAD commands or the LDAC input.
 The contents of both CODE and DAC registers are maintained during all software power-down states, so that when the DAC is returned to a normal operating mode, it returns to its previously stored output settings. Any CODE for a commands issued during software power-down

or LOAD commands issued during software power-down states continue to update the register contents. The SW_CLEAR command clears the contents of the CODE and DAC registers to the user-programmable default values. The SW_RESET command resets all configuration registers to their power-on default states, while resetting the CODE and DAC registers to zero scale.

The contents of the CODE register hold pending DAC

output settings which can later be loaded into the DAC registers. The CODE register can be updated using both

CODE and CODE_LOAD user commands. The contents

Internal Reference

The MAX5803/MAX5804/MAX5805 include an internal precision voltage reference that is software selectable to be 2.048V, 2.500V, or 4.096V. When an internal reference is selected, that voltage is available on the REF pin for other external circuitry (see the <u>Typical Operating</u> *Circuits*) and can drive a 25k Ω load.

External Reference

The external reference input features a typical input impedance of 100k Ω and accepts an input voltage from +1.24V to V_{DD}. Connect an external voltage supply between REF and GND to apply an external reference. The MAX5803/4/5 power up and reset to external reference mode. Visit <u>www.maximintegrated.</u> <u>com/products/references</u> for a list of available external voltage-reference devices.

AUX Input

The MAX5803/MAX5804/MAX5805 provide an asynchronous $\overline{\text{AUX}}$ (active-low) input. Use the CONFIG command to program the device to use the input in one of the following modes: $\overline{\text{CLR}}$ (default), $\overline{\text{GATE}}$, or disabled.

CLR Mode

In $\overline{\text{CLR}}$ mode, the $\overline{\text{AUX}}$ input performs an asynchronous level sensitive CLEAR operation when pulled low. If $\overline{\text{CLR}}$ is configured and asserted, all CODE and DAC

data registers are cleared to their default/return values as defined by the configuration settings. Other userconfiguration settings are not affected.

Some I²C interface commands are gated by CLR activity during the transfer sequence. If CLR is issued during a command write sequence, any gated commands within the sequence are ignored. If CLR is issued during an I²C command read sequence, the exchange continues as normal, however the data read back may be stale. The user may determine the state of the $\overline{\text{CLR}}$ input by issuing a status read. In all cases, the I²C interface continues to function according to protocol, however slave ACK pulses beyond the command acknowledge are not sent for gated write commands (notifying the µP that these instructions are being ignored). Any nongated commands appearing in the transfer sequence are fully acknowledged and executed. In order for the gating condition to be removed, remove CLR prior to a recognized START condition, meeting tCLRSTA requirements.

GATE Mode

Use of the GATE mode provides a means of momentarily holding the DAC in a user-selectable default/return state, returning the DAC to the last programmed state upon removal. The MAX5803/MAX5804/MAX5805 also feature a software-accessible GATE command. While asserted in GATE mode, the AUX pin does not interfere with RETURN, CODE, or DAC register updates and related load activity. The user may determine the gate status of the device by issuing a status read. I²C readbacks of CODE and DAC register content while gated continue to return the current register values, which may differ from the actual DAC output level.

The MAX5803/MAX5804/MAX5805 provide a dedicated asynchronous LDAC (active-low) input. The LDAC input performs an asynchronous level sensitive LOAD operation when pulled low. Use of the LDAC input mode provides a means of updating multiple devices together as a group. Users wishing to control the DAC update instance independently of the I/O instruction should hold LDAC high during programming cycles. Once programming is complete, LDAC may be strobed and the new CODE register content is loaded into the DAC latch output. Users wishing to load new DAC data in direct response to I/O CODE register activity should connect LDAC permanently low; in this configuration, the MAX5803/

LDAC Input

MAX5804/MAX5805 DAC output updates in response to each completed I/O CODE instruction update edge. A software LOAD command is also provided.

The $\overline{\text{LDAC}}$ operation does not interact with the user interface directly. However, in order to achieve the best possible glitch performance, timing with respect to the interface update edge should follow t_{LDH} specifications when issuing CODE commands. Using the software LOAD command with the Broadcast ID provides a software-based means of synchronously updating several MAX5803/MAX5804/MAX5805 devices on a shared bus.

V_{DDIO} Input

The MAX5803/MAX5804/MAX5805 feature a separate supply pin (V_{DDIO}) for the digital interface (1.8V to 5.5V). If present, connect V_{DDIO} to the I/O supply of the host processor.

I²C Serial Interface

The MAX5803/MAX5804/MAX5805 feature an I²C-/ SMBus[™]-compatible, 2-wire serial interface consisting of a serial data line (SDA) and a serial clock line (SCL). SDA and SCL enable communication between the MAX5803/ MAX5804/MAX5805 and the master at clock rates up to 400kHz. Figure 1 shows the 2-wire interface timing diagram. The master generates SCL and initiates data transfer on the bus. The master device writes data to the MAX5803/MAX5804/MAX5805 by transmitting the proper slave address followed by the command byte and then the data word. Each transmit sequence is framed by a START (S) or Repeated START (Sr) condition and a STOP (P) condition. Each word transmitted to the MAX5803/ MAX5804/MAX5805 is 8 bits long and is followed by an acknowledge clock pulse.

A master reading data from the MAX5803/MAX5804/ MAX5805 must transmit the proper slave address followed by a series of nine SCL pulses for each byte of data requested. The MAX5803/MAX5804/MAX5805 transmit data on SDA in sync with the master-generated SCL pulses. The master acknowledges receipt of each byte of data. Each read sequence is framed by a START or Repeated START condition, a not acknowledge, and a STOP condition. SDA operates as both an input and an open-drain output. A pullup resistor, typically 4.7k Ω is required on SDA. SCL operates only as an input. A pullup resistor, typically 4.7k Ω , is required on SCL if there are multiple masters on the bus, or if the single master has an open-drain SCL output.

Series resistors in line with SDA and SCL are optional. Series resistors protect the digital inputs of the MAX5803/ MAX5804/MAX5805 from high voltage spikes on the bus lines and minimize crosstalk and undershoot of the bus signals. The MAX5803/MAX5804/MAX5805 can accommodate bus voltages higher than VDD up to a limit of 5.5V; bus voltages lower than V___ are not recommended and may result in significantly increased interface currents. The MAX5803/MAX5804/MAX5805 digital inputs are double buffered. Depending on the command issued through the serial interface, the CODE register(s) can be loaded without affecting the DAC register(s) using the write command. To update the DAC registers, either drive the AUX input low while in LDAC mode to asynchronously update the DAC output, or use the software LOAD command.

I²C START and STOP Conditions

SDA and SCL idle high when the bus is not in use. A master initiates communication by issuing a START condition. A START condition is a high-to-low transition on SDA with SCL high. A STOP condition is a low-to-high transition on SDA while SCL is high (Figure 2). A START condition from the master signals the beginning of a transmission to the MAX5803/MAX5804/MAX5805. The master terminates transmission and frees the bus by issuing a STOP condition. The bus remains active if a Repeated START condition is generated instead of a STOP condition.

I²C Early STOP and Repeated START Conditions

The MAX5803/MAX5804/MAX5805 recognize a STOP condition at any point during data transmission except if the STOP condition occurs in the same high pulse as a START condition. Transmissions ending in an early STOP condition do not impact the internal device settings. If STOP occurs during a readback byte, the transmission is terminated and a later read mode request begins transfer of the requested register data from the beginning (this applies to combined format I²C read

Table 1	. I2C SI	ave Addro	ess LSBs
---------	----------	-----------	----------

A[6:2] = 00110					
ADDR	A1	AO			
V _{DD}	1	1			
N.C.	1	0			
GND	0	0			

mode transfers only, interface verification mode transfers will be corrupted, see Figure 2.)

I²C Slave Address

The slave address is defined as the seven most significant bits (MSBs) followed by the R/W bit. See Figure 4. The five most significant bits are 00110 with the 2 LSBs determined by ADDR as shown in Table 1. Setting the R/W bit to 1 configures the MAX5803/MAX5804/MAX5805 for read mode. Setting the R/W bit to 0 configures the MAX5803/MAX5803/MAX5804/MAX5805 for write mode. The slave address is the first byte of information sent to the MAX5803/MAX5804/MAX5805 after the START condition.

The MAX5803/MAX5804/MAX5805 have the ability to detect an unconnected state on the ADDR input for additional address flexibility; if leaving the ADDR input unconnected, be certain to minimize all loading on the pin (i.e. provide a landing for the pin, but do not allow any board traces). Using the ADDR input, up to three devices can be run on a single I²C bus

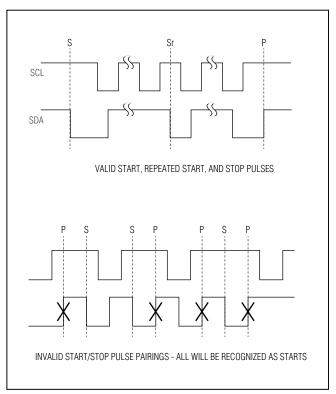


Figure 2. I²C START, Repeated START, and STOP Conditions

I²C Broadcast Address

A broadcast address is provided for the purpose of updating or configuring all MAX5803/MAX5804/MAX5805 devices on a given I²C bus. All MAX5803/MAX5804/ MAX5805 devices acknowledge and respond to the broadcast device address 00110010. The broadcast mode is intended for use in write mode only (as indicated by $R/\overline{W} = 0$ in the address given).

I²C Acknowledge

In write mode, the acknowledge bit (ACK) is a clocked 9th bit that the MAX5803/MAX5804/MAX5805 use to handshake receipt of each byte of data as shown in Figure 3. The MAX5803/MAX5804/MAX5805 pull down SDA during the entire master-generated 9th clock pulse if the previous byte is successfully received. Monitoring ACK allows for detection of unsuccessful data transfers. An unsuccessful data transfer occurs if a receiving device is busy or if a system fault has occurred. In the event of an unsuccessful data transfer, the bus master will retry communication.

In read mode, the master pulls down SDA during the 9th clock cycle to acknowledge receipt of data from the MAX5803/MAX5804/MAX5805. An acknowledge is sent by the master after each read byte to allow data transfer to continue. A not-acknowledge is sent when the master reads the final byte of data from the MAX5803/MAX5804/ MAX5805, followed by a STOP condition.

I²C Command Byte and Data Bytes

A command byte follows the slave address. A command byte is typically followed by two data bytes unless it is the last byte in the transmission. If data bytes follow the command byte, the command byte indicates the address of the register that is to receive the following two data bytes. The data bytes are stored in a temporary

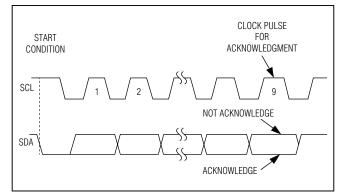


Figure 3. I²C Acknowledge

register and then transferred to the appropriate register during the ACK periods between bytes. This avoids any glitching or digital feedthrough to the DAC while the interface is active.

I²C Write Operations

A master device communicates with the MAX5803/ MAX5804/MAX5805 by transmitting the proper slave address followed by command and data words. Each transmit sequence is framed by a START or Repeated START condition and a STOP condition as described above. Each word is 8 bits long and is always followed by an acknowledge clock (ACK) pulse as shown in Figure 4 and Figure 5. The first byte contains the address of the MAX5803/MAX5804/MAX5805 with R/W = 0 to indicate a write. The second byte contains the register (or command) to be written and the third and fourth bytes contain the data to be written. By repeating the register address plus data pairs (Byte #2 through Byte #4 in Figure 4 and Figure 5), the user can perform multiple register writes using a single I²C command sequence. There is no limit as to how many registers the user can write with a single command. The MAX5803/MAX5804/ MAX5805 support this capability for all user-accessible write mode commands.

Combined Format I²C Readback Operations

Each readback sequence is framed by a START or Repeated START condition and a STOP condition. Each word is 8 bits long and is followed by an acknowledge clock pulse as shown in Figure 6. The first byte contains the address of the MAX5803/MAX5804/MAX5805 with R/W = 0 to indicate a write. The second byte contains the register that is to be read back. There is a Repeated START condition, followed by the device address with $R/\overline{W} = 1$ to indicate a read and an acknowledge clock. The master has control of the SCL line but the MAX5803/ MAX5804/MAX5805 take over the SDA line. The final two bytes in the frame contain the register data readback followed by a STOP condition. If additional bytes beyond those required to readback the requested data are provided, the MAX5803/MAX5804/MAX5805 will continue to readback ones. Readback of the RETURN register is supported for the RETURN command (B[23:20] = 0111). Readback of the CODE register is supported for the CODE command (B[23:20] = 1000). Readback of the DAC register is supported for all LOAD commands (B[23:20] = 1001, 1010, or 1011).

Readback of all other registers is not directly supported. All requests to read unsupported registers read back the device's current status and configuration settings as shown in <u>Table 2</u>. The status register contains information on the current clear, gate, and load status of the device (with a one indicating an asserted status), as well as user configuration settings for the reference, power-down, <u>AUX</u> mode, and default operation.

Interface Verification I²C Readback Operations

While the MAX5803/MAX5804/MAX5805 support standard I²C readback of selected registers, it is also capable of functioning in an interface verification mode. This mode is accessed any time a readback operation follows an executed write mode command. In this mode, the last executed three-byte command is read back in its entirety. This behavior allows verification of the interface.

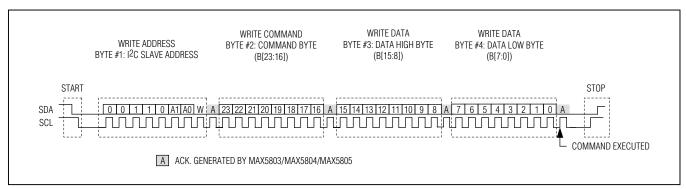


Figure 4. I²C Single Register Write Sequence

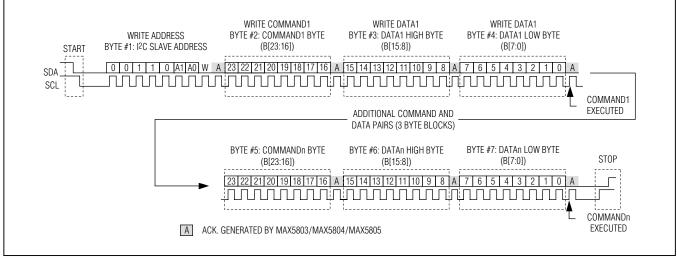


Figure 5. Multiple Register Write Sequence (Standard I²C Protocol)

Sample command sequences are shown in Figure 7. The first command transfer is given in write mode with R/W = 0 and must be run to completion to qualify for interface verification readback. There is now a STOP/START pair or Repeated START condition required, followed by the readback transfer with R/W = 1 to indicate a read and an acknowledge clock from the MAX5803/MAX5804/MAX5805. The master still has control of the SCL line but the MAX5803/MAX5804/MAX5805 take over the SDA line. The final three bytes in the frame contain the command and register data written in the first transfer presented for readback, followed by a STOP condition. If additional bytes beyond those required to read back the requested

data are provided, the MAX5803/MAX5804/MAX5805 will continue to read back ones.

It is not necessary for the write and read mode transfers to occur immediately in sequence. I²C transfers involving other devices do not impact the MAX5803/MAX5804/ MAX5805 readback mode. Toggling between readback modes is based on the length of the preceding write mode transfer. Combined format I²C readback operation is resumed if a write command greater than two bytes but less than four bytes is supplied. For commands written using multiple register write sequences, only the last command executed is read back. For each command written, the readback sequence can only be completed

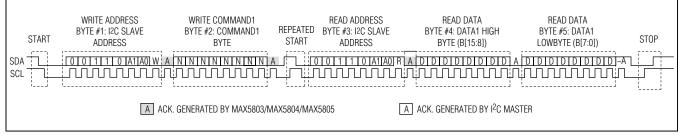


Figure 6. Standard I²C Register Read Sequence

	CON	MAN	ID BY	TE (F	REQU	EST)			REA	DBAC	K DA	TA H	IIGH E	вуте			REA	DBAC	CK DA	TA L	OW E	ЗҮТЕ	
B23	B22	B21	B20	B19	B18	B17	B16	B15	B14	B13	B12	B11	B10	B 9	B8	B7	B6	B5	B4	B3	B2	B1	B0
0	0	0	0	х	х	х	х	0	1	0	1	0		/_ID[2 (000)	2:0]			MA MA	ART_ X580 X580	3 = 0) 4 = 0)	(8A (92		
0	1	1	1	Х	Х	Х	Х			R	ETUR	N[11:	4]			R	ETUF	RN[3:0)]	0	0	0	0
1	0	0	0	Х	Х	Х	Х			(CODE	[11:4]				CODI	Ξ[3:0]		0	0	0	0
1	0	0	1	Х	Х	Х	Х				DAC[[11:4]					DAC	[3:0]		0	0	0	0
1	0	1	0	Х	Х	Х	Х				DAC[[11:4]					DAC	[3:0]		0	0	0	0
1	0	1	1	Х	Х	Х	Х				DAC[[11:4]					DAC	[3:0]		0	0	0	0
		Any	other	comr	mand			CLR	LOAD	GATE	1		RF[3:0]		PD[1:0]	A	AB[2:0]	[DF[2:0)]

Table 3. DAC Data Bit Positions

PART	B15	B14	B13	B12	B11	B10	B 9	B8	B7	B 6	B 5	B 4	B 3	B2	B1	B0
MAX5803	D7	D6	D5	D4	D3	D2	D1	D0	Х	Х	Х	Х	Х	Х	Х	Х
MAX5804	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	Х	Х	Х	Х	Х	Х
MAX5805	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	Х	Х	Х	Х

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one time; partial and/or multiple attempts to readback executed in succession will not yield usable data.

I²C Compatibility

The MAX5803/MAX5804/MAX5805 are fully compatible with existing I²C systems. SCL and SDA are high-impedance inputs; SDA provides an open drain which pulls the data line low to transmit data or ACK pulses. Figure 8 shows a typical I²C application.

I²C User-Command Register Map

This section lists the user-accessible commands and registers for the MAX5803/MAX5804/MAX5805.

Table 4 provides detailed information about the I²C Command Registers.

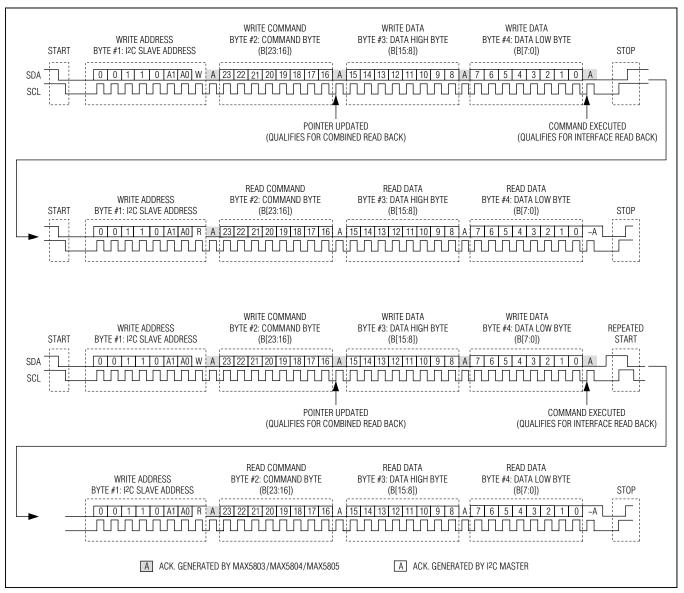


Figure 7. Interface Verification I²C Register Read Sequences

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CODE Command

The CODE command (B[23:20] = 1000) updates the CODE register content for the DAC. Changes to the CODE register content based on this command will not affect the DAC output directly unless the LDAC input is in a low state. Otherwise, a subsequent hardware or software LOAD operation will be required to move this content to the active DAC latch. This command is gated when $\overline{\text{CLR}}$ is asserted, updates to this register are ignored while the register is being cleared. See <u>Table 3</u> and Table 4.

LOAD Command

The LOAD command (B[23:20] = 1001) updates the DAC latch register content by uploading the current contents of the CODE register. This command is gated when $\overline{\text{CLR}}$ is asserted, updates to this register are ignored while the register is being cleared. See Table 3 and Table 4.

CODE_LOAD Command

The CODE_LOAD command (B[23:20] = 1010 and 1011) updates the CODE register contents as well as the DAC register content of the DAC. This command is gated when $\overline{\text{CLR}}$ is asserted, updates to these registers are ignored while the register is being cleared. See Table 3

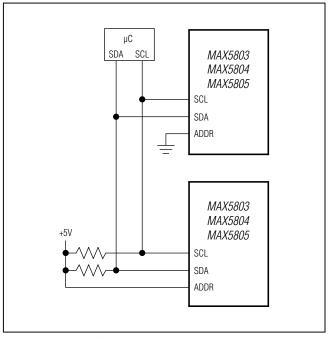


Figure 8. Typical I²C Application Circuit

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	ŝ	2	Ì		ŝ	ŝ										_			_	-	_	_	ć	
DAC COMMANDS	SS SS	770	2	020	20	<u>0</u>			2	±	2			2	8	8		8	5	8	8	<u>-</u>	8	
CODE		0	0	0	×	×	×	×			0 -	DDE REGISTI DATA[11:4]	CODE REGISTER DATA[11:4]				COD	CODE REGISTER DATA[3:0]	STER	×	×	×	×	Writes data to the CODE register
LOAD	-	0	0	-	×	×	×	×	×	×	×	×	×	×	×	×	×	× ×	×	×	×	×	×	Transfers data from the CODE registers to the DAC register
CODE_LOAD	-	0	-	0	×	×	×	×		0	DDE A	ND DAC RE DATA[11:4]	CODE AND DAC REGISTER DATA[11:4]	STER			COD REGISI	CODE AND DAC REGISTER DATA[30]	DAC -A[3:0]	×	×	×	×	Simultaneously writes data to the CODE register while updating DAC register
CODE_LOAD	-	0		-	×	×	×	×			DDE A	ND DAC RE DATA[11:4]	CODE AND DAC REGISTER DATA[11:4]	STER			COD REGISI	CODE AND DAC REGISTER DATA[30]	DAC -A[3:0]	×	×	×	×	Simultaneously writes data to the CODE register while updating DAC register
RETURN	0	-	-	-	×	×	×	×		R	TURN F	IEGISTI	RETURN REGISTER DATA[11:4]	م[11:4]			RETUF	RETURN REGISTER DATA(3:0]	ISTER]	×	×	×	×	Updates the RETURN register contents for the DAC

Table 4. I²C Commands Summary

												•												
COMMAND	B23	B22	B21	B20	B19	B18	B17	B16	B15	B14	B13	B12	B11	B10	B9	B8	B7 E	BG	B5 E	B4 B3	3 B2	2 B1	BO	DESCRIPTION
CONFIGURATION COMMANDS	N CON	IMAND:	s																					
REF	0	0	-	0	evinΩ oV = 0 ni9 evinΩ = t	tlusted = 0 NO zyswlA = t	Ref Mode 00 = EXT 01 = 2.5V 10 = 2.0V 11 = 4.1V	/lode EXT 2.5V 2.0V 4.1V	×	×	×	×	×	×	×	×	×	×	×	× ×	×	×	×	Sets the reference operating mode.
SOFTWARE	0	0	-	-	×		Type: 000 = END 001 = GATE 100 = CLR 101 = RST Other = No Effect	iffect Tect	×	×	×	×	×	×	×	×	×	×	×	× ×	×	×	×	Executes a software operation of the type chosen
POWER	0	-	0	0	×	×	×	×	×	×	×	×	×	×	×	×	Power Mode: 00 = DAC 01 = 14Ω 10 = 100 kΩ 11 = HIZ		×	× ×	×	×	×	Sets the Power mode
CONFIG	0	-	0	-	×	×	×	×	×	×	×	×	×	×	×	×	×	×	AUX 011 = 110 = 111 = Other =	AUX Mode: 011 = GATE 110 = CLEAR 111 = NONE Other = No Effect	×	×	×	Updates the function of the <u>AUX</u> input
DEFAULT	0	-	-	0	×	×	×	×	×	×	×	*	×	×	×	*	Defaul 000 001 = 010 011 = 100 = Other =	Default Values: 000 = POR 001 = ZERO 010 = MID 011 = FULL 100 = RETURN Other = No Effect		× ×	×	×	×	Sets the default value for the DAC
NO OPERATION COMMANDS		ANDS																						
	0	0	0	0	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	These commands
No Operation	۲	-	-	-	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	×	will have no ellect on the part.
Reserved Commands: Any commands not specifically listed above are reserved for Maxim internal use only.	mands	: Any c	comma	nds nc	ot speci	ifically	listed a	above a	ire rese	rved fo	r Maxin	n intern	ial use	only.										

Ultra-Small, Single-Channel, 8-/10-/12-Bit Buffered Output Voltage DACs with Internal Reference and I²C Interface

REF Command

The REF (B[23:20] = 0010) command updates the global reference setting used for the DAC. Set B[17:16] = 00 to use an external reference for the DAC or set B[17:16] to 01, 10, or 11 to select either the 2.5V, 2.048V, or 4.096V internal reference, respectively.

If RF3 (B19) is set to zero (default) in the REF command, the REF I/O will not be driven by the internal reference circuit, saving current. If RF3 is set to one, the REF I/O will be driven by the internal reference circuit, consuming an additional 25μ A (typ) of current when the reference is powered; when the reference is powered down, the REF I/O will be high-impedance.

If RF2 (B18) is set to zero (default) in the REF command, the reference will be powered down any time the DAC is powered down (in STANDBY mode). If RF2 (B18) is set to one, the reference will remain powered even if the DAC is powered down, allowing continued operation of external circuitry. In this mode, the 1 μ A shutdown state is not available. See <u>Table 5</u>.

Table 5. REF (0010) Command Format

SOFTWARE Commands

The SOFTWARE (B[23:20] = 0011) commands provide a means of issuing several flexible software actions. See Table 6.

The SOFTWARE Command Action Mode is selected by B[18:16]:

- END (000): Used to end any active gate operation, returning to normal operation (default).
- GATE (001): DAC contents will be gated to their DEFAULT selected values until the gate condition is removed.
- CLEAR (100): All CODE and DAC contents will be cleared to their DEFAULT selected values.
- RESET (101): All CODE, DAC, RETURN, and configuration registers reset to their power-up defaults (including REF, POWER, and CONFIG settings), simulating a power cycle reset.

OTHER: No effect.

B23	B22	B21	B20	B19	B18	B17	B16	B15	B14	B13	B12	B11	B10	B 9	B8	B7	B 6	B 5	B4	B 3	B2	B1	B0
0	0	1	0	RF3	RF2	RF1	RF0	Х	Х	Х	Х	Х	X	Х	Х	Х	Х	Х	Х	Х	Х	Х	X
RE	F COI	MMAI	ND	0 = REF Not driven 1 = REF Driven	0 = Off in Standby 1 = On in Standby	Ref M 00 = 01 = 10 = 11 =	EXT 2.5V				Don't	Care							Don't	Care			
DEF	AULT	VAL	UES	0	0	0	0	Х	Х	X	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х
		CO	MMA	ND B,	YTE					DA	TA HI	GH B'	YTE					DA	TA LO	DW B	ΥTE		

Table 6. SOFTWARE (0011) Command Format

B23	B22	B21	B20	B19	B18	B17	B16	B15	B14	B13	B12	B11	B10	B 9	B8	B7	B6	B5	B4	B 3	B2	B1	B0
0	0	1	1	Х	SW2	SW1	SW0	Χ	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	X	Х	Х	Х	X
	Soft\ OMM			Don't Care	00 00 10 10 0t	Mode: 1: GA 1: GA 0: CL 01: RS her: N Effect	D TE R ST Jo				Don't	Care							Don't	Care			
DEF	AULT	VAL	JES	Х	0	0	0	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х
		CO	MMA	ND B'	YTE					DA	TA HI	GH B`	YTE					DA	TA LO	DW B	ΥTΕ		

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POWER Command

The MAX5803/MAX5804/MAX5805 feature a softwarecontrolled POWER mode command (B[23:20] = 0100).

In power-down, the DAC output is disconnected from the buffer and is grounded with either one of the two selectable internal resistors or set to high impedance. See <u>Table 7</u> and <u>Table 8</u> for the selectable internal resistor values in power-down mode. In power-down mode, the DAC register retains its value so that the output is restored when the device powers up. The serial interface remains active in power-down mode with all registers accessible.

In power-down mode, the internal reference can be powered down or it can be set to remain powered-on for external use. Also, in power-down mode, parts using the external reference do not load the REF pin. See Table 7.

Table 7. POWER (0100) Command Format

B23	B22	B21	B20	B19	B18	B17	B16	B15	B14	B13	B12	B11	B10	B9	B8	B7	B 6	B 5	B4	B3	B2	B1	B0
0	1	0	0	Х	Х	Х	Х	Х	Х	Х	X	Х	Х	Х	X	PD1	PD0	Х	X	X	Х	X	X
(POV)		Don't	: Care					Don't	Care				Mc 00 Nor 01 = 10	wer de: mal 1kΩ) =)kΩ Hi-Z			Don't	Care		
DEF	AULT	VAL	UES	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	0	0	Х	X	Х	Х	Х	Х
		СС) MM/	AND E	BYTE					DA	TA HI	GH B	YTE					DA	TA LO	DW BY	′ΤΕ		

Table 8. Selectable DAC Output Impedance in Power-Down Mode

PD1 (B7)	PD0 (B6)	OPERATING MODE
0	0	Normal operation
0	1	Power-down with internal $1k\Omega$ pulldown resistor to GND.
1	0	Power-down with internal 100k Ω pulldown resistor to GND.
1	1	Power-down with high-impedance output.

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CONFIG Command

DEFAULT Command

The CONFIG command (B[23:20] = 0101) updates the function of the \overline{AUX} input enabling its gate or clear (default) operation mode. See <u>Table 9</u>.

AUX Config settings are written by B[5:3]:

- GATE (011): AUX functions as a GATE. DAC code is gated to DEFAULT value input when pin is low.
- CLEAR (110): AUX functions as a CLR input (default). CODE and DAC content is cleared to DEFAULT value if pin is low.
- NONE (111): AUX functions are disabled.
- OTHER: AUX function is not altered.

DEFAULT (0110): The DEFAULT command selects the default value for the DAC. These default values are used for all future clear and gate operations. The new default setting is determined by bits DF[2:0]. See Table 10.

Available default values are:

POR (000):	DAC defaults to power-on reset value (default).
ZERO (001):	DAC defaults to zero scale.
MID (010):	DAC defaults to midscale.
FULL (011):	DAC defaults to full scale.
RETURN (100):	DAC defaults to value specified by the RETURN register
OTHER:	No effect, the default setting remains unchanged.

Note: The selected default values do not apply to resets initiated by SW_RESET commands or supply cycling, both of which return the DACs to the power-on reset state (zero scale).

Table 9. CONFIG (0101) Command Format

B23	B22	B21	B20	B19	B18	B17	B16	B15	B14	B13	B12	B11	B10	B 9	B 8	B7	B 6	B5	B 4	B 3	B2	B1	B 0
0	1	0	1	X	Х	Х	Х	Х	Х	Х	Х	Х	X	Х	Х	X	Х	AB2	AB1	AB0	X	X	X
CON	FIG C	OMM	IAND		Don't	Care					Don't	Care				Do Ca	-	011 110 111 Oth	(B Mo = GA = CLI = NC ner = Effect	ATE EAR DNE No	Do	n't Ca	are
DEFA	ULT \	/ALUE	ES	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	1	1	0	Х	Х	Х
		CO	MMA	ND B'	YTE					DA	ΓΑΗΙ	GH B,	YTE					DA	TA LO	DW BY	/TE		

Table 10. DEFAULT (0110) Command Format

B23	B22	B21	B20	B19	B18	B17	B16	B15	B14	B13	B12	B11	B10	B9	B8	B7	B 6	B 5	B 4	B 3	B2	B1	B0
0	1	1	0	X	Х	X	X	X	Х	Х	Х	Х	X	X	Х	DF2	DF1	DF0	Х	Х	Х	Х	X
	DEF# COM	AULT MAND)		Don't	: Care					Don't	Care				00 00 01 100 0	ult Va 00: PC 1: ZE 10: M 1: FU RET ther: I	RO ID ILL URN No		Dc	n't Ca	are	
DEF	AULT	VAL	JES	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	Х	0	0	0	Х	Х	Х	Х	Х
		CO	MMAI	ND B'	YTE					DA	TA HI	GH B'	YTE					DA	TA LO	DW B'	ΥTE		

RETURN Command

The RETURN command (B[23:20] = 0111) updates the RETURN register content for the DAC. If the DEFAULT configuration register is set to RETURN mode, the DAC will be cleared or gated to the RETURN register value in the event of a SW or HW CLEAR or GATE condition. It is not necessary to program this register if the DEFAULT = RETURN mode will not be used. The data format for the RETURN register is identical to that used for CODE and LOAD operations. See <u>Table 3</u> and <u>Table 4</u>.

Applications Information

Power-On Reset (POR)

When power is applied to V_{DD} , the DAC output is set to zero scale. To optimize DAC linearity, wait until the supplies have settled and the internal setup and calibration sequence completes (200µs, typ).

Power Supplies and Bypassing Considerations

Bypass V_{DD} with high-quality ceramic capacitors to a low-impedance ground as close as possible to the device. Minimize lead lengths to reduce lead inductance. Connect GND to the analog ground plane.

Layout Considerations

Digital and AC transient signals on GND can create noise at the output. Connect GND to form the star ground for the DAC system. Refer remote DAC loads to this system ground for the best possible performance. Use proper grounding techniques, such as a multilayer board with a low-inductance ground plane, or star connect all ground return paths back to the MAX5803/MAX5804/ MAX5805 GND. Carefully layout the traces between channels to reduce AC cross-coupling. Do not use wirewrapped boards and sockets. Use shielding to maximize noise immunity. Do not run analog and digital signals parallel to one another, especially clock signals. Avoid routing digital lines underneath the MAX5803/MAX5804/ MAX5805 package.

Definitions

Integral Nonlinearity (INL)

INL is the deviation of the measured transfer function from a straight line drawn between two codes once offset and gain errors have been nullified.

Differential Nonlinearity (DNL)

DNL is the difference between an actual step height and the ideal value of 1 LSB. If the magnitude of the DNL \leq 1 LSB, the DAC guarantees no missing codes and is monotonic. If the magnitude of the DNL \geq 1 LSB, the DAC output may still be monotonic.

Offset Error

Offset error indicates how well the actual transfer function matches the ideal transfer function. The offset error is calculated from two measurements near zero code and near maximum code.

Gain Error

Gain error is the difference between the ideal and the actual full-scale output voltage on the transfer curve, after nullifying the offset error. This error alters the slope of the transfer function and corresponds to the same percentage error in each step.

Zero-Scale Error

Zero-scale error is the difference between the DAC output voltage when set to code zero and ground. This includes offset and other die level nonidealities.

Full-Scale Error

Full-scale error is the difference between the DAC output voltage when set to full scale and the reference voltage. This includes offset, gain error, and other die level nonidealities.

Settling Time

The settling time is the amount of time required from the start of a transition, until the DAC output settles to the new output value within the converter's specified accuracy.

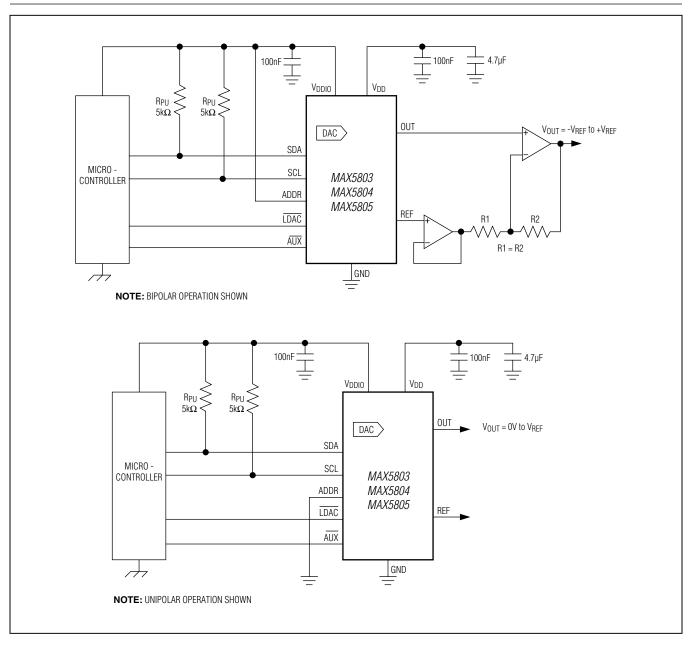
Digital Feedthrough

Digital feedthrough is the amount of noise that appears on the DAC output when the DAC digital control lines are toggled.

Digital-to-Analog Glitch Impulse

A major carry transition occurs at the midscale point where the MSB changes from low to high and all other bits change from high to low, or where the MSB changes from high to low and all other bits change from low to high. The duration of the magnitude of the switching glitch during a major carry transition is referred to as the digital-to-analog glitch impulse.

The digital-to-analog power-up glitch is the duration of the magnitude of the switching glitch that occurs as the device exits power-down mode.



Typical Operating Circuits

Ultra-Small, Single-Channel, 8-/10-/12-Bit Buffered Output Voltage DACs with Internal Reference and I²C Interface

Ordering Information

PART	PIN-PACKAGE	RESOLUTION (BIT)	INTERNAL REFERENCE TEMPCO (ppm/°C)
MAX5803ATB+T	10 TDFN-EP*	8	10 (typ), 25 (max)
MAX5803AUB+	10 µMAX	8	10 (typ), 25 (max)
MAX5804ATB+T	10 TDFN-EP*	10	10 (typ), 25 (max)
MAX5804AUB+	10 µMAX	10	10 (typ), 25 (max)
MAX5805AAUB+	10 µMAX	12	4 (typ), 12 (max)
MAX5805BATB+T	10 TDFN-EP*	12	10 (typ), 25 (max)
MAX5805BAUB+	10 µMAX	12	10 (typ), 25 (max)

Note: All devices are specified over the -40°C to +125°C temperature range.

+Denotes a lead(Pb)-free/RoHS-compliant package.

T = Tape and reel.

*EP = Exposed pad.

Chip Information

PROCESS: BICMOS

Package Information

For the latest package outline information and land patterns (footprints), go to <u>www.maximintegrated.com/packages</u>. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

PACKAGE TYPE	PACKAGE CODE	OUTLINE NO.	LAND PATTERN NO.
10 TDFN-EP	T1032N+1	<u>21-0429</u>	<u>90-0082</u>
10 µMAX	U10+2	<u>21-0061</u>	<u>90-0330</u>

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Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
0	11/12	Initial release	
1	2/13	Released the MAX5803/MAX5804. Updated the Electrical Characteristics.	2–8, 30
2	6/13	Released the MAX5803/MAX5804/MAX5805 TDFN packages.	30



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